

|                                   |                                       |  |  |             |
|-----------------------------------|---------------------------------------|--|--|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/651,134 |  | Applicant(s)/Patent Under<br>Reexamination<br>GOLLA, PRASAD N. |             |
|                                   | Examiner<br>SALMAN AHMED              |  | Art Unit<br>2419   | Page 1 of 1 |

#### U.S. PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-2002/0097672 A1                               | 07-2002         | Barbas et al.       | 370/216        |
| * | B | US-2003/0210705 A1                               | 11-2003         | Seddigh et al.      | 370/419        |
| * | C | US-2004/0131079 A1                               | 07-2004         | Hegde et al.        | 370/466        |
| * | D | US-2004/0246976 A1                               | 12-2004         | Balakrishnan et al. | 370/395.41     |
| * | E | US-2004/0255202 A1                               | 12-2004         | Wong et al.         | 714/043        |
| * | F | US-2005/0018602 A1                               | 01-2005         | Labovitz, Craig H.  | 370/229        |
| * | G | US-2006/0149524 A1                               | 07-2006         | Kalyanaraman et al. | 703/013        |
| * | H | US-7,190,896 B1                                  | 03-2007         | Wang et al.         | 398/30         |
| * | I | US-7,317,731 B2                                  | 01-2008         | Seddigh et al.      | 370/419        |
| * | J | US-7,363,285 B2                                  | 04-2008         | Kalyanaraman et al. | 707/2          |
| * | K | US-7,415,028 B1                                  | 08-2008         | Allam, Bhasker      | 370/395.54     |
|   | L | US-  |                 |                     |                |
|   | M | US-  |                 |                     |                |

#### FOREIGN PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name         | Classification |
|---|---|--|-----------------|---------|--------------|----------------|
|   | N | EP1511238A2                                      | 07-2004         | EPO     | GOLLA PRASAD | H04L 12/56     |
|   | O |  |                 |         |              |                |
|   | P |  |                 |         |              |                |
|   | Q |  |                 |         |              |                |
|   | R |  |                 |         |              |                |
|   | S |  |                 |         |              |                |
|   | T |  |                 |         |              |                |

#### NON-PATENT DOCUMENTS

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)   |
|---|---|---|
|   | U | Recovery from control plane failures in the CR-LDP signalling protocol; Jing Wu; Savoie, J.M.; Montuno, D.Y.; Mouftah, H.T.; Communications, 2003. ICC '03. IEEE International Conference on Volume 2, 11-15 May 2003 Page(s):1309 - 1313 vol.2   |
|   | V | Link Management Protocol Automatic Control Plane Configuration Extensions for Resilient Ring-based Architectures; Perello, J.; Escalona, E.; Spadaro, S.; Comellas, J.; Junyent, G.; Transparent Optical Networks, 2006 International Conference on Volume 3, 18-22 June 2006 Page(s):165 - 168 |
|   | W | Recovery from control plane failures in the CR-LDP and O-UNI signalling protocols; Wu, J.; Savoie, M.; Mouftah, H.T.; Montuno, D.Y.; Design of Reliable Communication Networks, 2003. (DRCN 2003). Proceedings. Fourth International Workshop on 19-22 Oct. 2003 Page(s):139 - 146              |
|   | X |   |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.